

T1G4003532-FS

35W, 32V, DC – 3.5 GHz, GaN RF Power Transistor

TriQuint 
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Applications

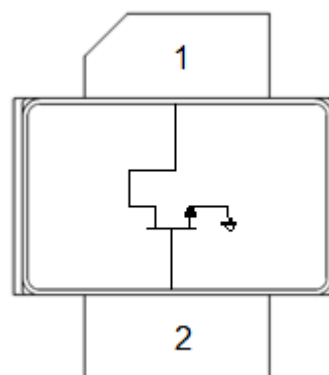
- Military radar
- Civilian radar
- Professional and military radio communications
- Test instrumentation
- Wideband or narrowband amplifiers
- Jammers



Product Features

- Frequency: DC to 3.5 GHz
- Output Power (P3dB): 37 W at 3.5 GHz
- Linear Gain: >16 dB at 3.5 GHz
- Operating Voltage: 32 V
- Low thermal resistance package

Functional Block Diagram



General Description

The TriQuint T1G4003532-FS is a 37 W (P_{3dB}) discrete GaN on SiC HEMT which operates from DC to 3.5 GHz. The device is constructed with TriQuint's proven 0.25 μm process, which features advanced field plate techniques to optimize power and efficiency at high drain bias operating conditions. This optimization can potentially lower system costs in terms of fewer amplifier line-ups and lower thermal management costs.

Lead-free and RoHS compliant

Evaluation Boards are available upon request.

Pin Configuration

Pin #	Symbol
1	Vd/RF OUT
2	Vg/RF IN
Flange	Source

Ordering Information

Material No.	Part No.	Description	ECCN
1092931	T1G4003532-FS	Packaged part: Flangeless	EAR99
1095349	T1G4003532-FS/FL-EVB1	2.7-3.5 GHz Eval. Board	EAR99

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Specifications

Absolute Maximum Ratings

Parameter	Rating
Drain to Gate Voltage, $V_d - V_g$	40 V
Drain Voltage, V_d	+40 V
Gate Voltage, V_g	-8 to 0 V
Drain Current, I_d	4.5 A
Gate Current, I_g	-7.5 to 7.5 mA
Power Dissipation, P_{diss}	40 W
RF Input Power, CW, $T = 25^\circ\text{C}$	38.75 dBm
Channel Temperature, T_{ch}	275 $^\circ\text{C}$
Mounting Temperature (30 sec)	320 $^\circ\text{C}$
Storage Temperature	-40 to 150 $^\circ\text{C}$

Operation of this device outside the parameter ranges given above may cause permanent damage. These are stress ratings only, and functional operation of the device at these conditions is not implied. Refer to the Median Life Time plot on pg. 3 for additional information regarding channel temperature.

Recommended Operating Conditions

Parameter	Min	Typical	Max	Units
V_d		32		V
I_{dq}		150		mA
I_d (Peak Current)		2400		mA
V_g		-3.9		V
Channel Temperature, T_{ch}		200		$^\circ\text{C}$
Power Dissipation, P_{diss} (CW)			24.5	W
Power Dissipation, P_{diss} (Pulse)			35	W

Electrical specifications are measured at specified test conditions. Specifications are not guaranteed over all recommended operating conditions.

Electrical Specifications

Recommended operating conditions apply unless otherwise specified: $T_A = 25^\circ\text{C}$, $V_d = 32\text{ V}$, $I_{dq} = 150\text{ mA}$, $V_g = -3.9\text{ V}$

RF Characteristics

Characteristics	Symbol	Min	Typ	Max	Units
Load Pull Performance at 1.0 GHz ($V_{DS} = 32\text{ V}$, $I_{DQ} = 150\text{ mA}$; Pulse: 100μs, 20%)					
Linear Gain	G_{LIN}		23.0		dB
Output Power at 3 dB Gain Compression	P_{3dB}		40.1		W
Drain Efficiency at 3 dB Gain Compression	DE_{3dB}		73.0		%
Power-Added Efficiency at 3 dB Gain Compression	PAE_{3dB}		72.5		%
Gain at 3 dB Compression	G_{3dB}		20.0		dB
Load Pull Performance at 3.5 GHz ($V_{DS} = 32\text{ V}$, $I_{DQ} = 150\text{ mA}$; Pulse: 100μs, 20%)					
Linear Gain	G_{LIN}		18.8		dB
Output Power at 3 dB Gain Compression	P_{3dB}		42.6		W
Drain Efficiency at 3 dB Gain Compression	DE_{3dB}		62.1		%
Power-Added Efficiency at 3 dB Gain Compression	PAE_{3dB}		60.5		%
Gain at 3 dB Compression	G_{3dB}		15.8		dB
Performance at 3.5 GHz in the 2.7 to 3.5 GHz Eval. Board ($V_{DS} = 32\text{ V}$, $I_{DQ} = 150\text{ mA}$; Pulse: 100μs, 20%)					
Linear Gain	G_{LIN}	16.0	17.0		dB
Output Power at 3 dB Gain Compression	P_{3dB}	33.0	37.0		W
Drain Efficiency at 3 dB Gain Compression	DE_{3dB}	53.0	57.0		%
Power Added Efficiency at 3 dB Compression	PAE_{3dB}	48.0	54.0		%
Gain at 3 dB Compression	G_{3dB}	13.0	14.0		dB
Narrow Band Performance at 3.50 GHz ($V_{DS} = 32\text{ V}$, $I_{DQ} = 150\text{ mA}$, CW at P1dB)					
Impedance Mismatch Ruggedness	VSWR			10:1	

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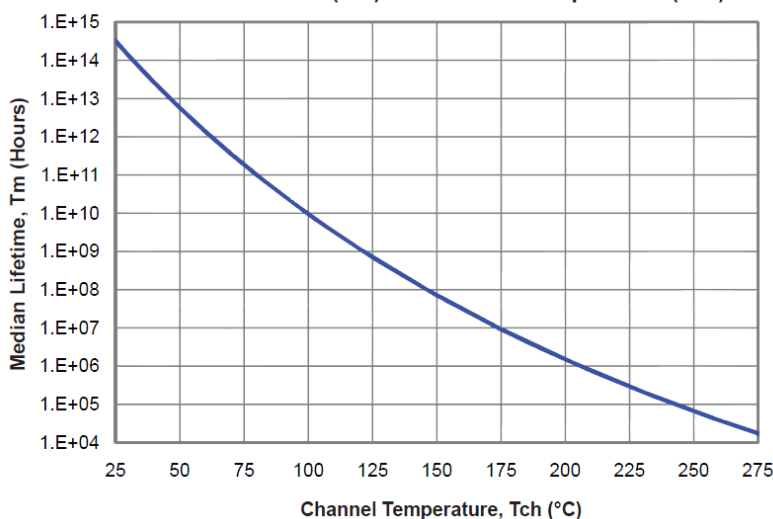
Specifications (cont.)

Thermal and Reliability Information

Test Conditions	T_{CH} (°C)	Θ_{JC} (°C/W)
DC at 85 °C	200	4.7

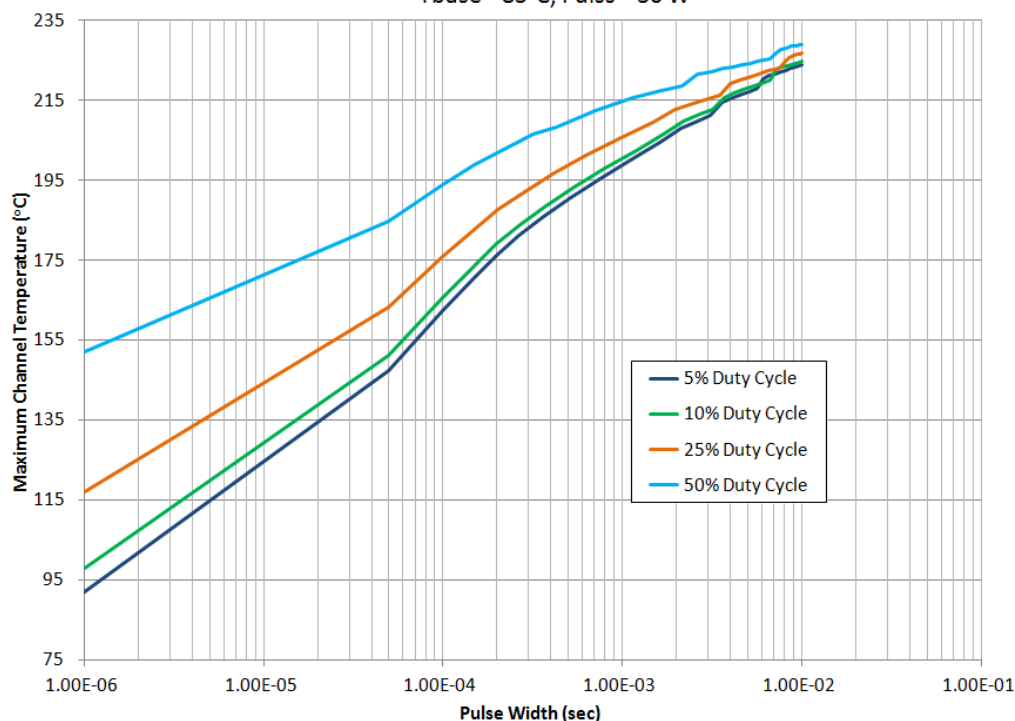
Note: Thermal resistance, Θ_{JC} , measured to bottom of package

Median Lifetime (T_m) vs. Channel Temperature (T_{ch})



Maximum Channel Temperature

$T_{base} = 85^\circ\text{C}$, $P_{diss} = 30\text{ W}$



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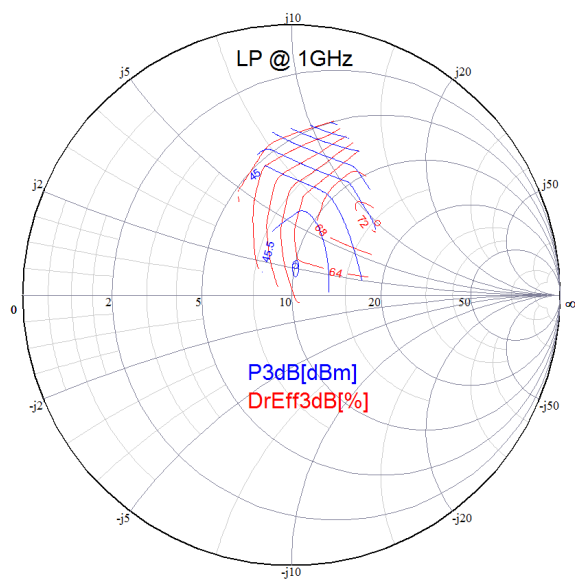
Load Pull Smith Chart

RF performance that the device typically exhibits when placed in the specified impedance environment. The impedances are not the impedances of the device, they are the impedances presented to the device via an RF circuit or load-pull system. The impedances listed follow an optimized trajectory to maintain high power and high efficiency.

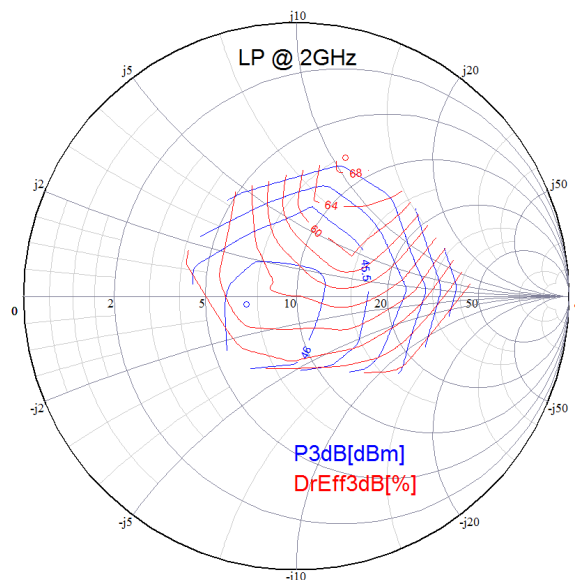
Test Conditions: $V_{DS} = 32\text{ V}$, $I_{DQ} = 150\text{ mA}$

Test Signal: Pulse Width = 100 μsec , Duty Cycle = 20%

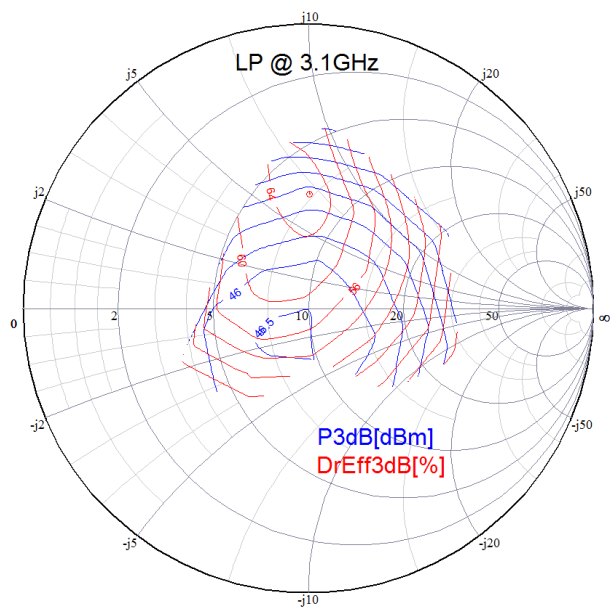
Load-Pull Data at 1.0 GHz



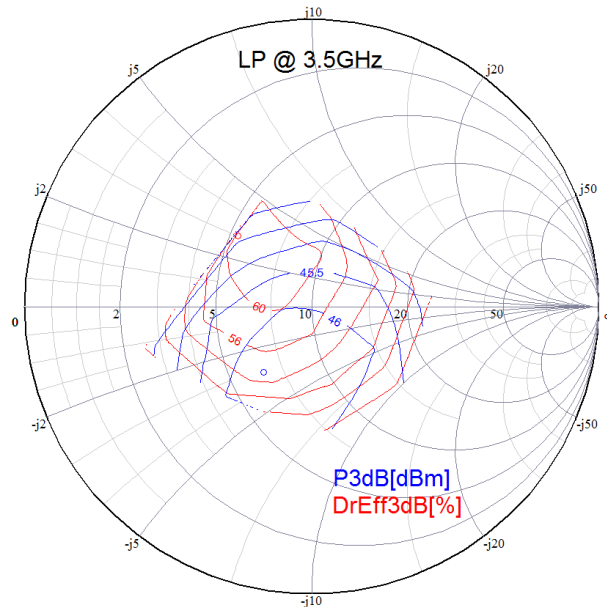
Load-Pull Data at 2.0 GHz



Load-Pull Data at 3.1 GHz



Load-Pull Data at 3.5 GHz



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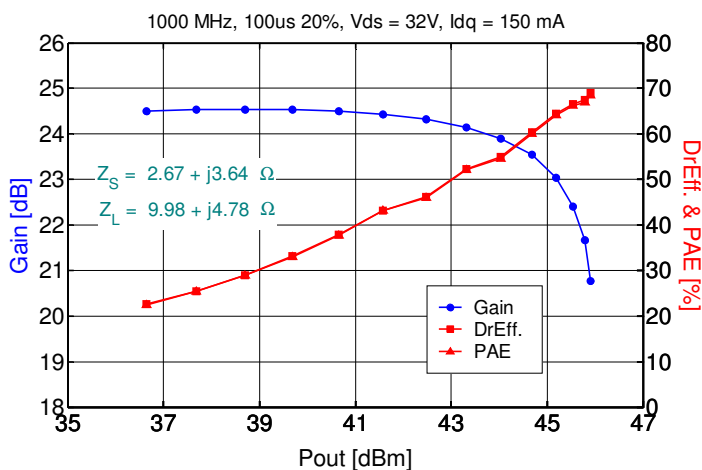
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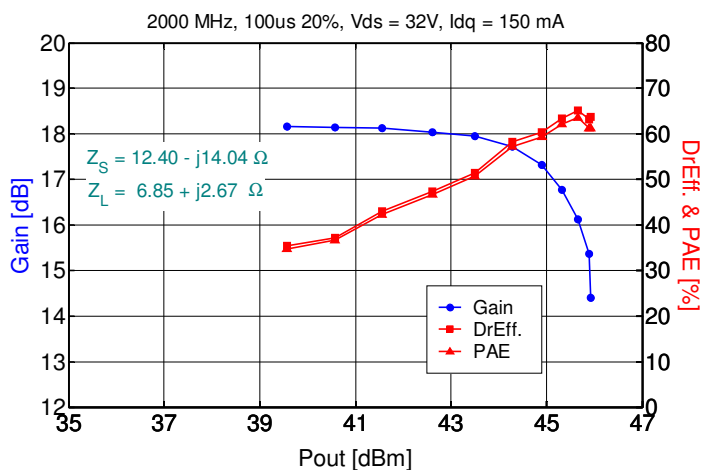
Typical Performance (cont.)

Performance is based on compromised impedance point and measured at DUT reference plane.

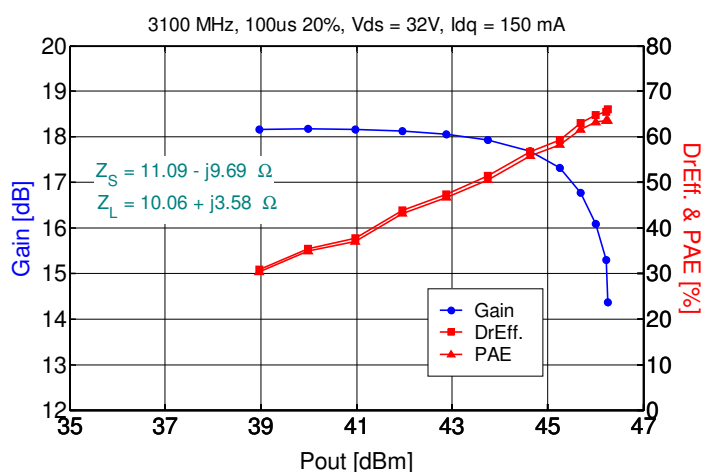
T1G4003532-FS Gain DrEff. and PAE vs. Pout



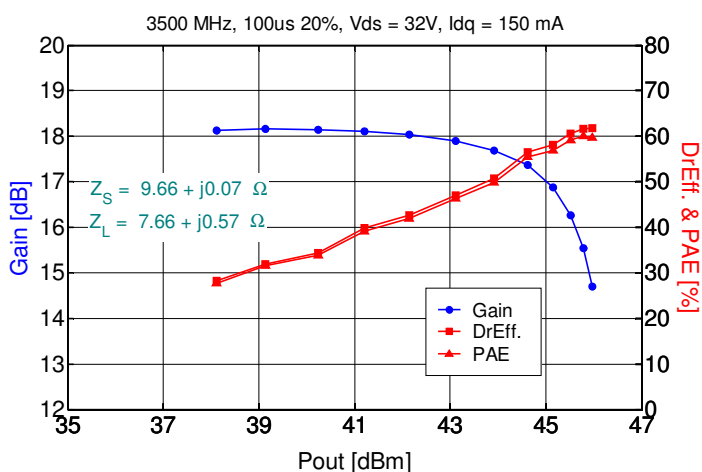
T1G4003532-FS Gain DrEff. and PAE vs. Pout



T1G4003532-FS Gain DrEff. and PAE vs. Pout



T1G4003532-FS Gain DrEff. and PAE vs. Pout



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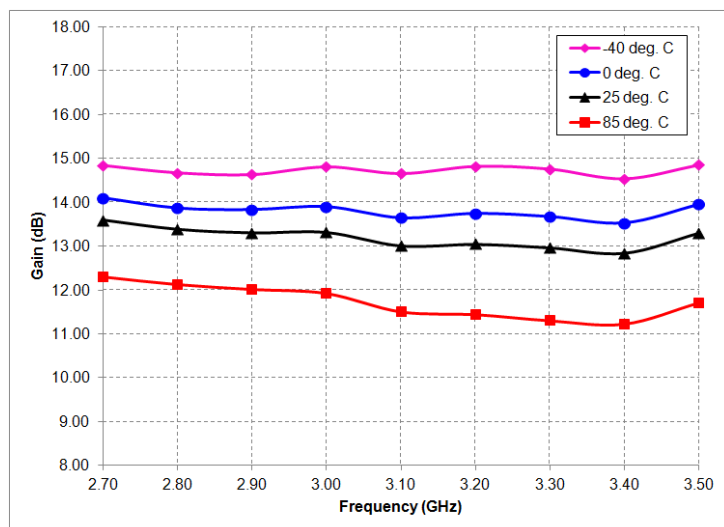
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Performance over Temperature: Gain, Efficiency and Output Power

Performance measured in TriQuint's 2.7 GHz to 3.5 GHz Evaluation Board at 3 dB compression.

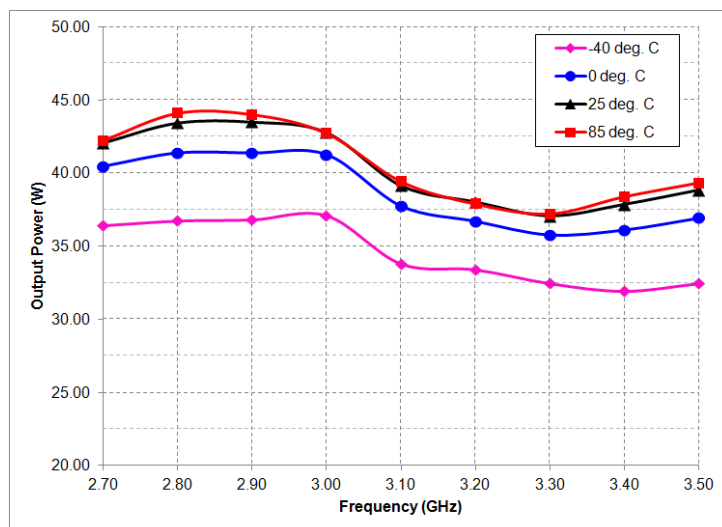
T1G4003532-FS Gain vs. Temp.

$V_{DS} = 32\text{ V}$, $I_{DQ} = 150\text{ mA}$; Pulse: 100 μs , 20%



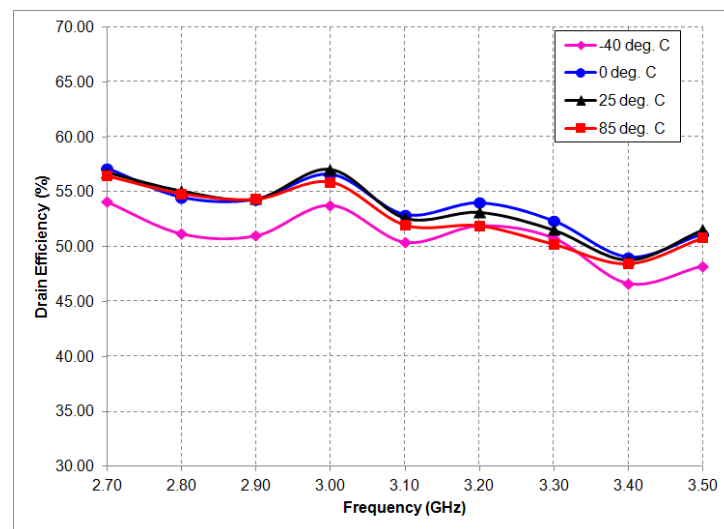
T1G4003532-FS Power vs. Temp.

$V_{DS} = 32\text{ V}$, $I_{DQ} = 150\text{ mA}$; Pulse: 100 μs , 20%



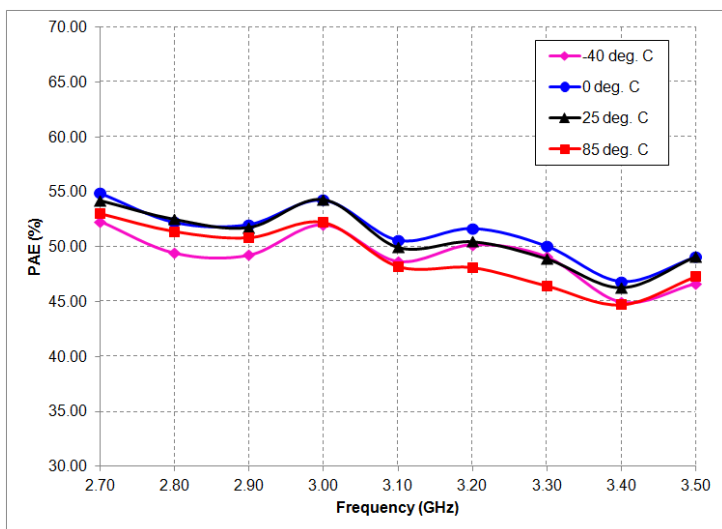
T1G4003532-FS Drain Eff. vs. Temp.

$V_{DS} = 32\text{ V}$, $I_{DQ} = 150\text{ mA}$; Pulse: 100 μs , 20%



T1G4003532-FS PAE vs. Temp.

$V_{DS} = 32\text{ V}$, $I_{DQ} = 150\text{ mA}$; Pulse: 100 μs , 20%



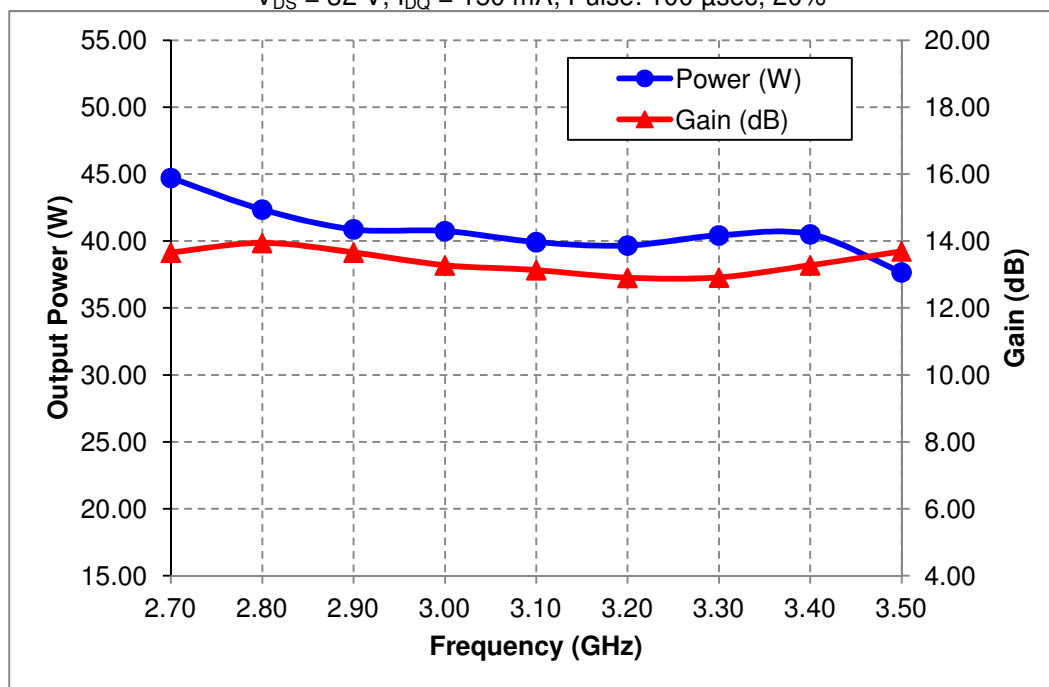
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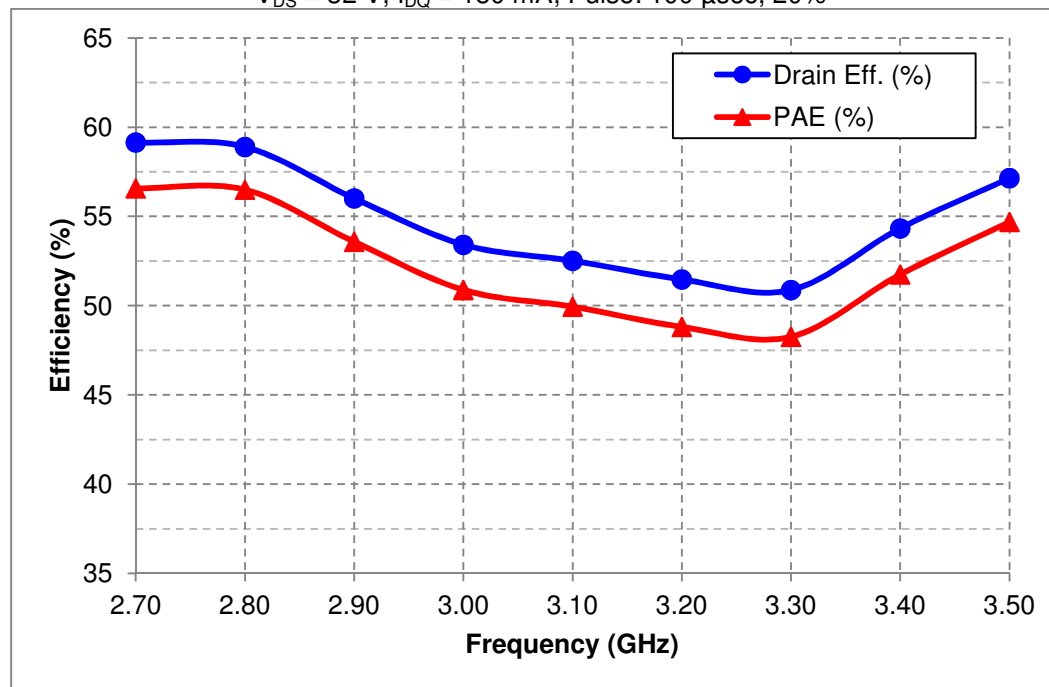


Evaluation Board Performance: 2.7 to 3.5 GHz

Output Power and Gain at 3 dB Compression
 $V_{DS} = 32\text{ V}$, $I_{DQ} = 150\text{ mA}$; Pulse: 100 μsec , 20%



Drain Efficiency and Power Added Efficiency at 3 dB Compression
 $V_{DS} = 32\text{ V}$, $I_{DQ} = 150\text{ mA}$; Pulse: 100 μsec , 20%

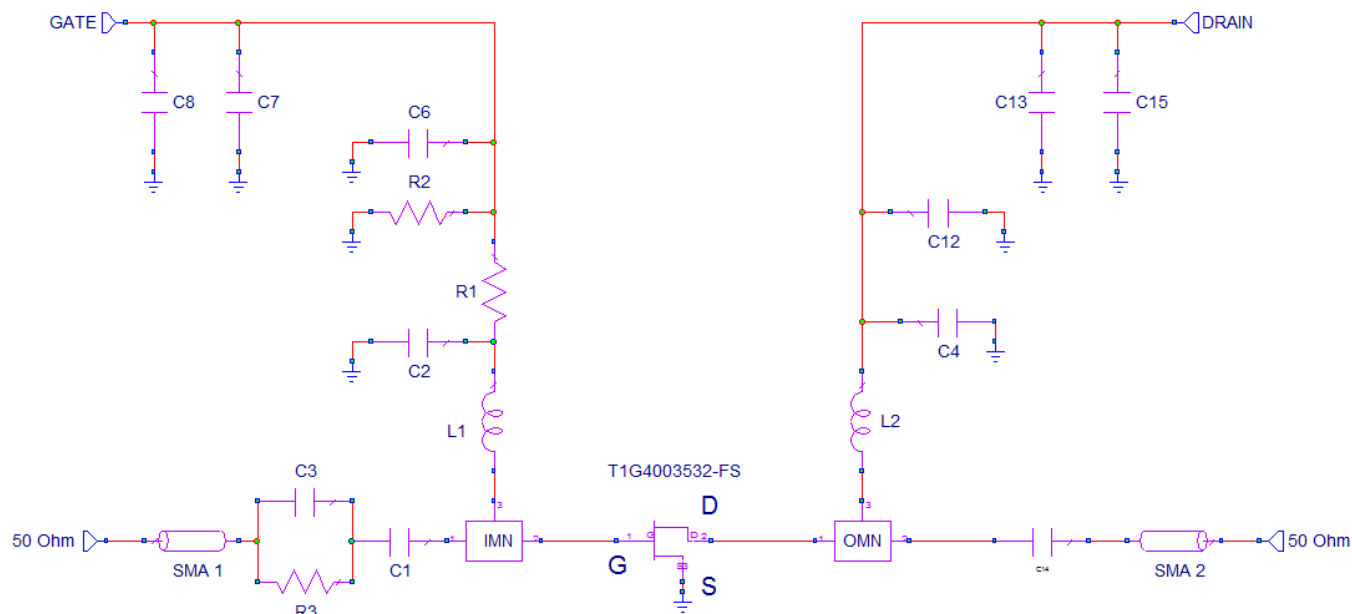


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Application Circuit



Bias-up Procedure

Vg set to -5.0V

Vd set to 32 V

Adjust Vg more positive until quiescent Id is 150 mA.
This will be ~ Vg = -3.9 V typical

Apply RF signal

Bias-down Procedure

Turn off RF signal

Turn off Vd and wait 1 second to allow drain
capacitor dissipation

Turn off Vg

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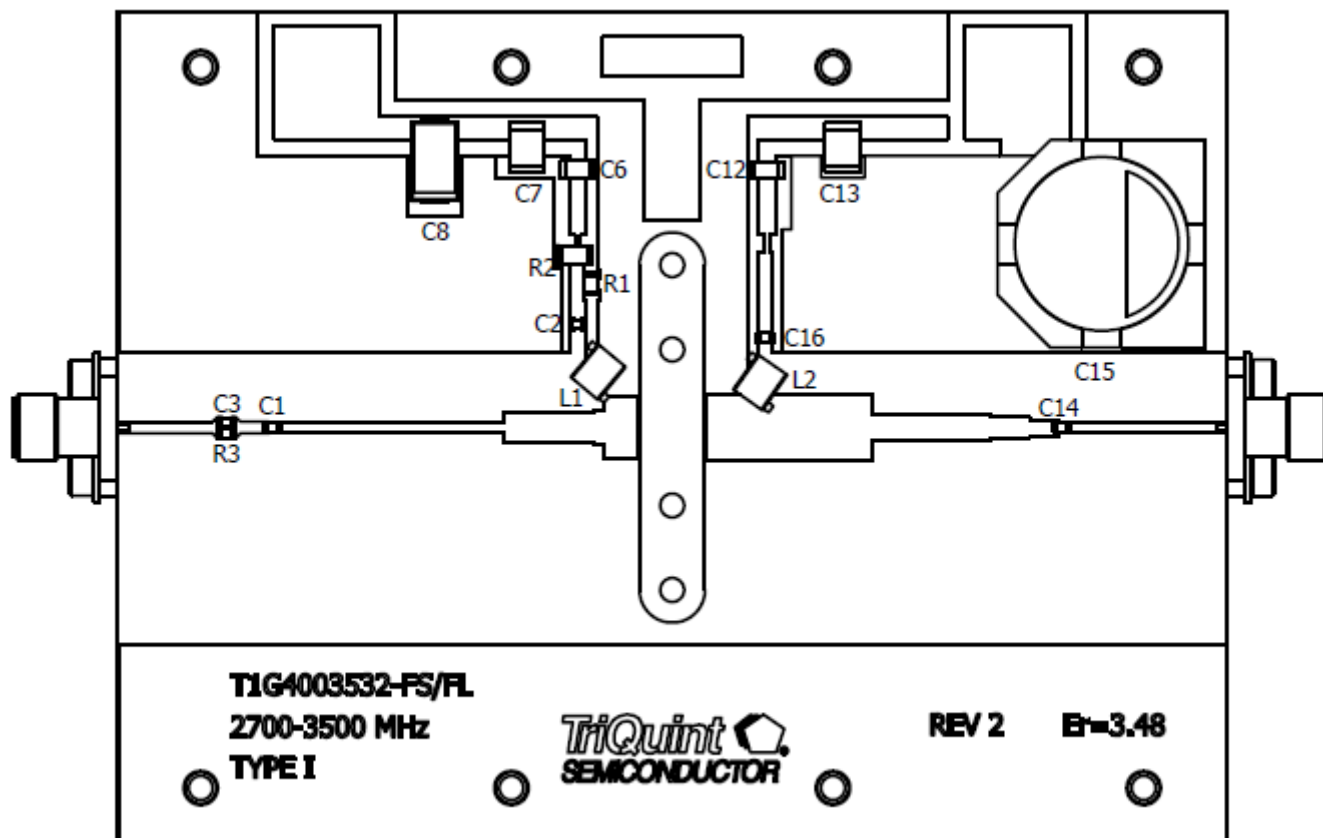
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Applications Information

Evaluation Board Layout

Top RF layer is 0.020" thick Rogers RO4350B, $\epsilon_r = 3.48$.

The pad pattern shown has been developed and tested for optimized assembly at TriQuint Semiconductor. The PCB land pattern has been developed to accommodate lead and package tolerances.



Bill of Materials

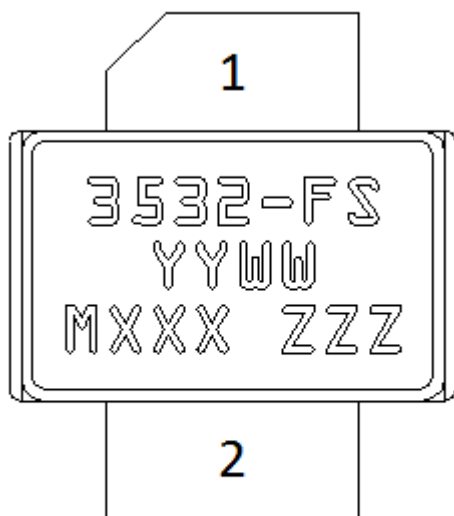
Reference Des.	Value	Qty	Manufacturer	Part Number
C1, C2, C3, C14	10 pF	4	ATC	600S100FT250XT
C6, C12	0.1 uF	2	Kemet	C1206C104K1RACTU
C7, C13	1.0 uF	2	AVX	18121C105KAT2A
C8	22 uF	1	Vishay Sprague	293D226X9035E2TE3
C15	470 uF	1	Illinois Capacitor	477KXM035M
C16	2400 pF	1	Dielectric Labs	C08BL242X_5SN_X0T
L1, L2	8.0 nH	2	Coilcraft	A03TJLB
R1	12.1 Ohms	1	Vishay Dale	CRCW120612R1FKEA
R2	1000 Ohms	1	Vishay Dale	CRCW12061K00FKEA
R3	97.6 Ohms	1	Vishay Dale	CRCW060397R6FKEA

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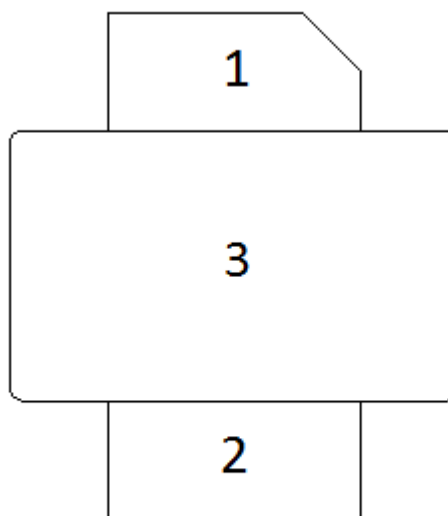
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PIN Description



TOP VIEW



BOTTOM VIEW

Pin	Symbol	Description
1	Vd/ RF OUT	Drain voltage/ RF Output matched to 50 ohms; see Application Circuit on page 9 as an example.
2	Vg/RF IN	Gate voltage/ RF Input matched to 50 ohms; see Application Circuit on page 9 as an example
3	Flange	Source connected to ground; see Application Circuit on page 9 as an example.

The T1G4003532-FS will be marked with the “3532” designator and a lot code marked below the part designator. The “YY” represents the last two digits of the calendar year the part was manufactured, the “WW” is the work week of the assembly lot start, the “MXXX” is the production lot number, and the “ZZZ” is an auto-generated serial number.

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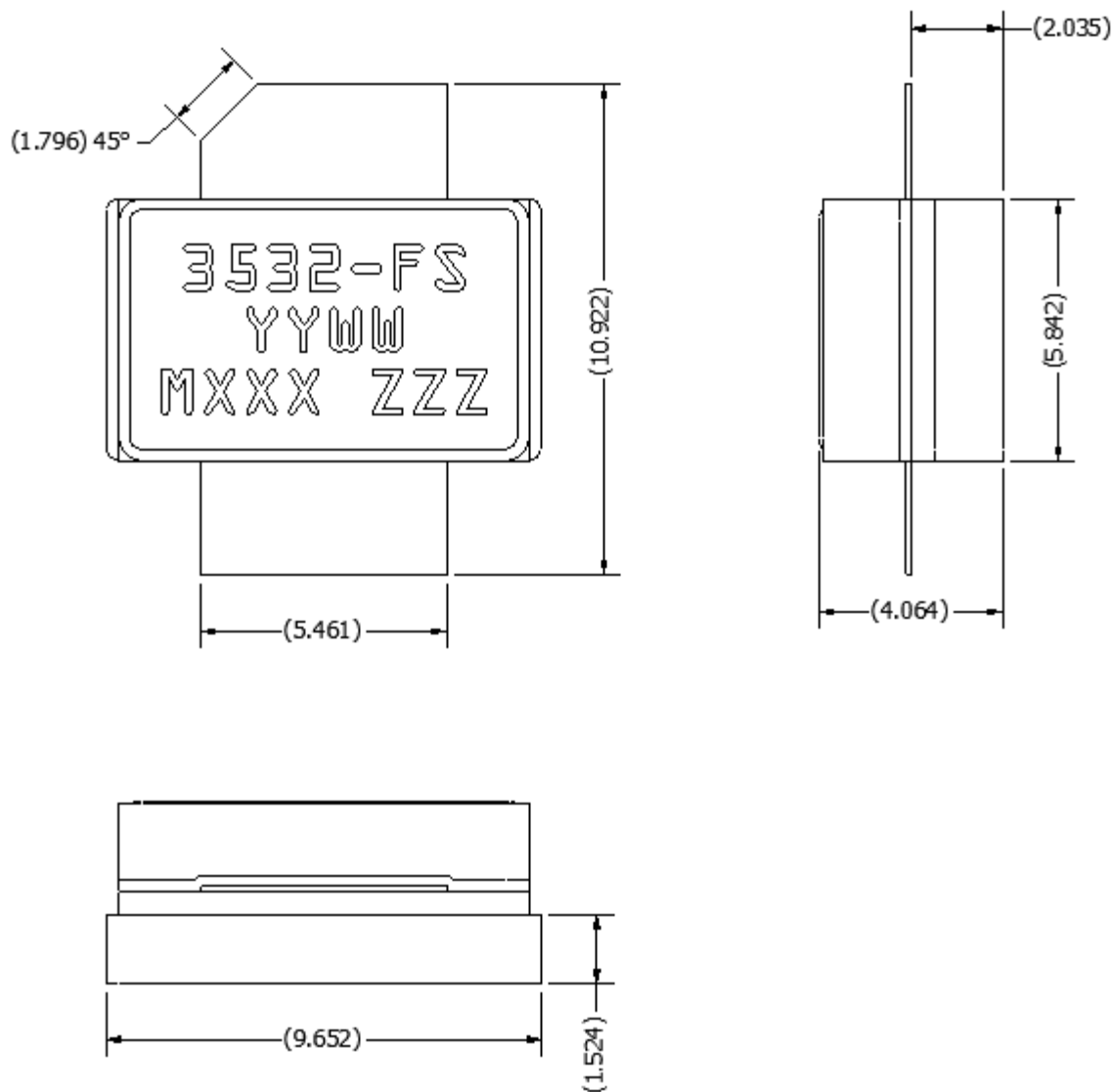
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Mechanical Information

Package Information and Dimensions

All dimensions are in millimeters.



This package is lead-free/RoHS-compliant. The plating material on the leads is NiAu. It is compatible with both lead-free (maximum 260 °C reflow temperature) and tin-lead (maximum 245°C reflow temperature) soldering processes.

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Product Compliance Information

ESD Information



Caution! ESD-Sensitive Device

ESD Rating: TBD
Value: TBD
Test: Human Body Model (HBM)
Standard: JEDEC Standard JESD22-A114

MSL Rating

Level 3 at +260 °C convection reflow
The part is rated Moisture Sensitivity Level 3 at 260 °C per JEDEC standard IPC/JEDEC J-STD-020.

ECCN

US Department of Commerce EAR99

Solderability

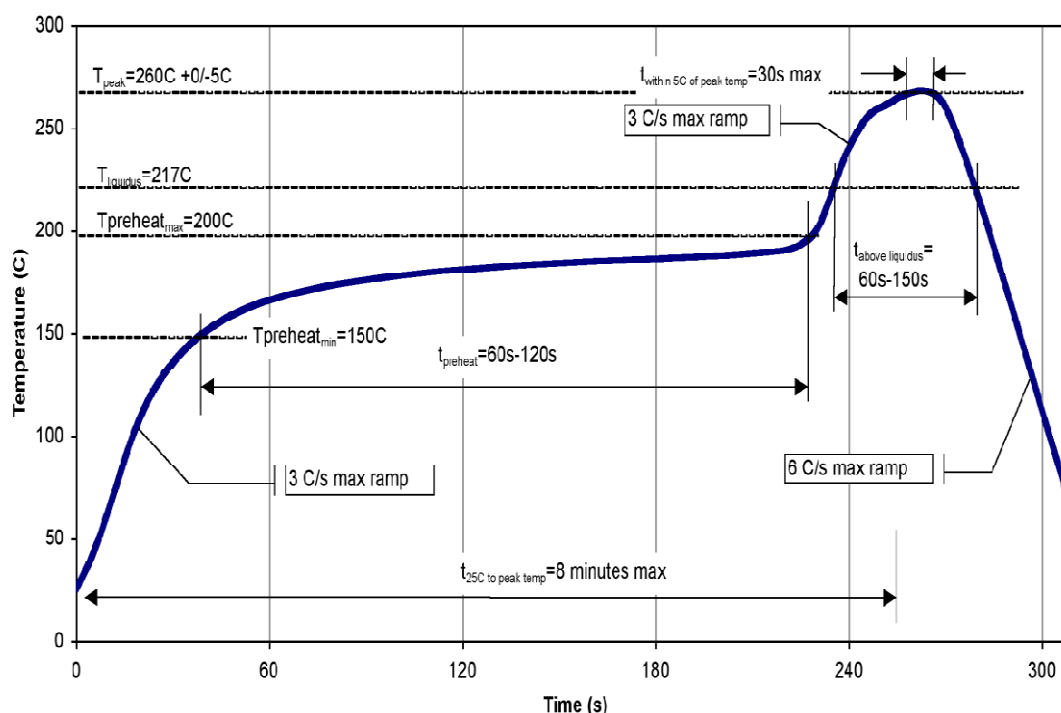
Compatible with the latest version of J-STD-020,
Lead free solder, 260 °C

This part is compliant with EU 2002/95/EC RoHS directive (Restrictions on the Use of Certain Hazardous Substances in Electrical and Electronic Equipment).

This product also has the following attributes:

- Lead Free
- Halogen Free (Chlorine, Bromine)
- Antimony Free
- TBBP-A ($C_{15}H_{12}Br_4O_2$) Free
- PFOS Free
- SVHC Free

Recommended Soldering Temperature Profile



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Contact Information

For the latest specifications, additional product information, worldwide sales and distribution locations, and information about TriQuint:

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